## Application/Control No. Applicant(s)/Patent Under Reexamination 10/685,039 WEBB ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Hiep T. Nguyen 2187 **U.S. PATENT DOCUMENTS** Date Document Number Name Classification Country Code-Number-Kind Code MM-YYYY US-6,751,721 06-2004 Webb et al. 712/10 Α US-В US-С US-D US-Ε US-F US-G US-Н USı US-US-Κ US-US-М **FOREIGN PATENT DOCUMENTS** Document Number Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R s Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

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